



Angular correlation studies on ¹⁷²Lu(¹⁷²Yb) in GaN and measurements at low temperatures

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1

 gallium nitride is a III-V semiconductor with large direct bandgap

- electroluminescence observed at room temperature by doping GaN with rare earths
- lateral structuring of devices by ion implantation (subsequent annealing required)
- investigation of the behaviour of rare earths in GaN
- $\gamma \gamma$ perturbed angular correlation (PAC) technique well suited

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Production and implantation at CERN (ISOLDE facility, *Isotope Separator OnLine*)

- it works well and the samples are strong
- the isotope ¹⁷²Lu is rarely available at ISOLDE (twice a year)
- 7 10 days from CERN to Bonn
- the beam is frequently contaminated with molecules of the same mass

Production and implantation on site (Bonn)

- irradiation of a thulium foil with ⁴He at the cyclotron, reaction $^{169}\text{Tm}(\alpha,n)^{172}\text{Lu}$
- implantation at the Bonn isotope separator
- weak samples but frequent production





Implantation procedure

- probe: ¹⁷²Lu is implanted in a 5×5 mm² sample
- sample: single crystalline GaN layer (11 μ m), with surface (0001), grown on a sapphire substrate
- implantation energy: 160 keV
- mean implantation depth: 30 nm

Annealing procedure

- in a RTA-furnace (Rapid Thermal Annealing)
- at 1300 K for 2 min under nitrogen atmosphere
- with a proximity cap (here: pure GaN)

Temperature dependence of the EFG





- Expected: nearly constant EFG
- lattice parameters are barely temperature dependent
- example: ¹⁸¹Hf (¹⁸¹Ta)

Temperature dependence of the EFG







4f shell in crystal electric field















Splitting of the 4f shell with **negative** lattice EFG







Splitting of the 4f shell with **negative** lattice EFG







PAC spectra of ¹⁷²Lu(¹⁷²Yb) in GaN

- annealed at 1300 K for 2 min
- measured from 13 K to 294 K

Temperature dependence of the damping













- the EFG at site of ¹⁷²Lu(¹⁷²Yb) in GaN was measured between 13 K and 294 K
- the strong temperature dependence of the 4f shell EFG at low temperatures could be explained with a simple model
- the current measurements support the assumption of a positive lattice EFG in GaN





Grazie.